

Notice of References Cited	Application/Control No. 09/630,454		Applicant(s)/Patent Under Reexam Liaw Wt AI.	
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U.S. PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Name	Classification ²	
A	US 4,346,170	08/24/82	Sano et al.	435	115
B	US 4,657,860	04/14/87	Nakanishi et al.	435	115
C	US 5,077,207	12/31/91	Shijo et al.	435	115
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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